

#### **ENTERPRISE D-SERIES**

# Ultra High Capacity PCIe Gen5 Data Center SSD to Reduce OPEX Costs

# PASCARI D205V

# **Sequential Read**

Up to 14,600 MB/s

# **Random Read**

Up to 3,000K IOPS

# Interface

PCIe 5.0 1x4 (Single port), 2x2 (Dual port)

### Capacity

122.88TB

### **Form Factor**

U.2, E3.S, E3.L

### DWPD

0.3



### **Product Features**

- NVMe 2.0
- 128 Namespaces
- Power Loss Protection (PLP)
- ISE, TCG Opal 2.0 support
- AES-XTS 256-bit Encryption
- Data Integrity and Protection
- End-to-End Data Path Protection
- Metadata Protection
- SECDED
- Sanitize
- NVMe-MI (Management Interface)
- SMBus



#### Solutions - D205V

	Form Factor U.2	
Capacity <sup>(2)</sup>	122.88ТВ	
Interface	PCIe 5.0 1x4, 2x2	
NVMe	2.0	
NAND Flash	3D QLC	
Performance <sup>(3,4,5)</sup>		
Sequential Read (MB/s)	14,600	
Sequential Write (MB/s)	3,200	
4K Random Read (IOPS)	3,000K	
16K Random Write (IOPS)	35K	
Read Latency (Typ., µs)	110	
Write Latency (Typ., µs)	12	
Power Consumption <sup>(6)</sup>		
Active (W)	25	
Idle (W)	5	
Endurance/Reliability		
DWPD <sup>(7)</sup>	0.3	
UBER	< 1 sector per 10 <sup>18</sup> bits read	
MTBF (million hours)	2.5	
Limited Warranty (years)	5	
	Temperature	
Operating Temp. (°C)	0 - 70	
Non-Operating Temp. (°C)	-40 - 85	
Physical Dimension		
Length (mm)	100.10	
Width (mm)	69.85	
Height (mm)	15.00	

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(2) T B = 10<sup>12</sup> bytes.
(3) Sequential Performance is based on FIO on Linux, 128KB, with QD=32, 1 job.
(4) Random Performance is based on FIO on Linux, random read 4KB data size, random write 16KB data size, QD=64, 8 jobs.
(5) Latency is measured with random workloads based on FIO on Linux, 4KB data size, QD=1, 1 job.
(6) Power consumption (Average RMS) is measured during the sequential read/write and random read/write operations performed by iometer with the conditions described in (2)(3).
(7) The results of DWPD are obtained in compliance with JESD219A Standards.



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#### Solutions - D205V

	Form Factor E3.S	
Capacity <sup>(2)</sup>	122.88TB	
Interface	PCIe 5.0 1x4, 2x2	
NVMe	2.0	
NAND Flash	3D QLC	
Performance <sup>(3,4,5)</sup>		
Sequential Read (MB/s)	14,600	
Sequential Write (MB/s)	3,200	
4K Random Read (IOPS)	3,000K	
16K Random Write (IOPS)	35К	
Read Latency (Typ., µs)	110	
Write Latency (Typ., µs)	12	
Power Consumption <sup>(6)</sup>		
Active (W)	25	
ldle (W)	5	
	Endurance/Reliability	
DWPD <sup>(7)</sup>	0.3	
UBER	< 1 sector per 10 <sup>18</sup> bits read	
MTBF (million hours)	2.5	
Limited Warranty (years)	5	
	Temperature	
Operating Temp. (°C)	0 - 70	
Non-Operating Temp. (°C)	-40 - 85	
Physical Dimension		
Length (mm)	112.75	
Width (mm)	76.00	
Height (mm)	7.50	

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(5) Latency is measured with random workloads based on FIO on Linux, 4KB data size, QD=1, 1 job.
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#### Solutions - D205V

	Form Factor E3.L	
Capacity <sup>(2)</sup>	122.88TB	
Interface	PCIe 5.0 1x4, 2x2	
NVMe	2.0	
NAND Flash	3D QLC	
Performance <sup>(3,4,5)</sup>		
Sequential Read (MB/s)	14,600	
Sequential Write (MB/s)	3,200	
4K Random Read (IOPS)	3,000K	
16K Random Write (IOPS)	35К	
Read Latency (Typ., µs)	110	
Write Latency (Typ., µs)	12	
Power Consumption <sup>(6)</sup>		
Active (W)	25	
Idle (W)	5	
	Endurance/Reliability	
DWPD <sup>(7)</sup>	0.3	
UBER	< 1 sector per 10 <sup>18</sup> bits read	
MTBF (million hours)	2.5	
Limited Warranty (years)	5	
	Temperature	
Operating Temp. (°C)	0 - 70	
Non-Operating Temp. (°C)	-40 - 85	
Physical Dimension		
Length (mm)	142.20	
Width (mm)	76.00	
Height (mm)	7.50	

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